	MAX207
<b>5-V MULTICHANNEL</b>	<b>RS-232 LINE DRIVER/RECEIVER</b>
	WITH +15-kV ESD PROTECTION

SLLS592B -	- OCTOBER	2003 - RE	VISED JA	NUARY 2004

<ul> <li>ESD Protection for RS-232 I/O Pins</li> <li>±15 kV – Human-Body Model</li> </ul>	DB OR DW PACKAGE (TOP VIEW)
<ul> <li>Meets or Exceeds the Requirements of TIA/EIA-232-F and ITU v.28 Standards</li> </ul>	
<ul> <li>Operates at 5-V V<sub>CC</sub> Supply</li> </ul>	
<ul> <li>Operates Up To 120 kbit/s</li> </ul>	RIN1 🛛 4 21 🗍 DIN5
• External Capacitors 4 $\times$ 0.1 $\mu$ F	
• Latch-Up Performance Exceeds 100 mA	
JESD 78, Class II	
Applications	GND 8 17 ROUT3
<ul> <li>Applications</li> <li>Battery-Powered Systems, PDAs,</li> </ul>	
Notebooks, Laptops, Palmtop PCs, an	$C_{1+} \downarrow_{10} 15 \downarrow_{10} V_{-}$
Hand-Held Equipment	
	C1– [ 12 13 ] C2+

#### description/ordering information

The MAX207 consists of five line drivers, three line receivers, and a dual charge-pump circuit with  $\pm$ 15-kV ESD protection pin to pin (serial-port connection pins, including GND). The device meets the requirements of TIA/EIA-232-F and provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 5-V supply. The devices operate at data signaling rates up to 120 kbit/s and a maximum of 30-V/µs driver output slew rate.

TA	PACKAGE <sup>†</sup>		PACKAGE <sup>†</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING
		Tube of 25	MAX207CDW	MAX2070		
0°C to 70°C	SOIC (DW)	Reel of 2000	MAX207CDWR	MAX207C		
	SSOP (DB)	Reel of 2000	MAX207CDBR	MA207C		
					MAX207IDW	144/2071
–40°C to 85°C	SOIC (DW)	Reel of 2000	MAX207IDWR	MAX2071		
	SSOP (DB)	Reel of 2000	MAX207IDBR	MB207I		

#### **ORDERING INFORMATION**

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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#### **MAX207 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER** WITH ±15-kV ESD PROTECTION SLLS592B - OCTOBER 2003 - REVISED JANUARY 2004

#### **Function Tables**

INPUT D <sub>IN</sub>	OUTPUT DOUT			
L	Н			
н	L			
H = high I	evel I = low			

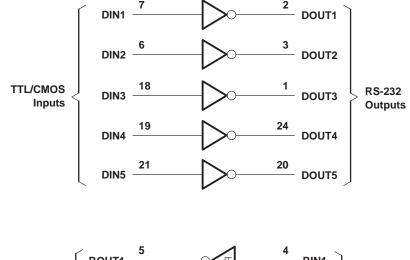
H = high level, L = lowlevel

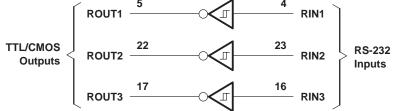
#### EACH RECEIVER

INPUT R <sub>IN</sub>	output <sup>R</sup> out
L	Н
Н	L
Open	Н
⊔ _ biab I	

H = high level, L = lowlevel, Open = input disconnected or connected driver off

#### logic diagram (positive logic)







## MAX207 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER WITH ±15-kV ESD PROTECTION

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#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> (see Note 1) Positive charge pump voltage range, V+ (see Note 1) Negative charge pump voltage range, V– (see Note 1)	$\ldots$ V <sub>CC</sub> – 0.3 V to 14 V
Input voltage range, V <sub>I</sub> : Drivers	
Receivers	±30 V
Output voltage range, V <sub>O</sub> : Drivers	$\dots V0.3 V$ to V+ + 0.3 V
Receivers	$\dots \dots -0.3$ V to V <sub>CC</sub> + 0.3 V
Short-circuit duration: D <sub>OUT</sub>	Continuous
Package thermal impedance, $\theta_{JA}$ (see Notes 2 and 3): DB package	
Operating virtual junction temperature, T <sub>J</sub>	
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltages are with respect to network GND.

- 2. Maximum power dissipation is a function of T<sub>J</sub>(max),  $\theta_{JA}$ , and T<sub>A</sub>. The maximum allowable power dissipation at any allowable ambient temperature is P<sub>D</sub> = (T<sub>J</sub>(max) T<sub>A</sub>)/ $\theta_{JA}$ . Operating at the absolute maximum T<sub>J</sub> of 150°C can affect reliability.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.

#### recommended operating conditions (see Note 4 and Figure 4)

			MIN	NOM	MAX	UNIT
	Supply voltage		4.5	5	5.5	V
VIH	Driver high-level input voltage	D <sub>IN</sub>	2			V
VIL	Driver low-level input voltage	D <sub>IN</sub>			0.8	V
V	Driver input voltage	D <sub>IN</sub>	0		5.5	
VI	Receiver input voltage		-30		30	V
-	Operating free-air temperature	MAX207C	0		70	
Τ <sub>Α</sub>		MAX207I	-40		85	°C

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu F$  at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.

# electrical characteristics over recommended ranges of supply voltage (unless otherwise noted) (see Note 4 and Figure 4)

	PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
ICC	Supply current	No load,	$V_{CC} = 5 V,$	$T_A = 25^{\circ}C$		11	20	mA

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu F$  at V<sub>CC</sub> = 5 V  $\pm$  0.5 V.



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#### **DRIVER SECTION**

#### electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 4)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
VOH	High-level output voltage	$D_{OUT}$ at $R_L = 3 \text{ k}\Omega$ to GND,	D <sub>IN</sub> = GND	5	9		V
VOL	Low-level output voltage	$D_{OUT}$ at $R_L = 3 \text{ k}\Omega$ to GND,	$D_{IN} = V_{CC}$	-5	-9		V
IIН	High-level input current	$V_I = V_{CC}$			15	200	μA
١ <sub>IL</sub>	Low-level input current	V <sub>I</sub> at 0 V			-15	-200	μA
los‡	Short-circuit output current	V <sub>CC</sub> = 5.5 V,	$V_{O} = 0 V$		±10	±60	mA
r <sub>o</sub>	Output resistance	$V_{CC}$ , V+, and V- = 0 V,	$V_{O} = \pm 2 V$	300			Ω

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V, and  $T_A = 25^{\circ}$ C.

<sup>‡</sup> Short-circuit durations should be controlled to prevent exceeding the device absolute power-dissipation ratings, and not more than one output should be shorted at a time.

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.

#### switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 4)

	PARAMETER	TEST C	TEST CONDITIONS		TYP†	MAX	UNIT
	Maximum data rate	$C_L = 50$ to 1000 pF, One D <sub>OUT</sub> switching,	R <sub>L</sub> = 3 kΩ to 7 kΩ, See Figure 1	120			kbit/s
<sup>t</sup> PLH (D)	Propagation delay time, low- to high-level output	C <sub>L</sub> = 2500 pF, all drivers loaded,	RL = 3 kΩ, See Figure 1		2		μs
<sup>t</sup> PHL (D)	Propagation delay time, high- to low-level output	C <sub>L</sub> = 2500 pF, all drivers loaded,	R <sub>L</sub> = 3 kΩ, See Figure 1		2		μs
t <sub>sk(p)</sub>	Pulse skew§	$C_{L} = 150 \text{ pF to } 2500 \text{ pF},$	$R_L = 3 k\Omega$ to 7 kΩ, See Figure 2		300		ns
SR(tr)	Slew rate, transition region (see Figure 1)	$C_L = 50 \text{ pF to } 1000 \text{ pF}$ $V_{CC} = 5 \text{ V}$	$R_L = 3 k\Omega$ to 7 kΩ,	3	6	30	V/µs

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, and T<sub>A</sub> = 25°C.

\$ Pulse skew is defined as  $|t_{PLH} - t_{PHL}|$  of each channel of the same device. NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.

#### **ESD** protection

PIN	TEST CONDITIONS	TYP	UNIT
D <sub>OUT</sub> , R <sub>IN</sub>	Human-Body Model	±15	kV



#### **RECEIVER SECTION**

# electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 4)

	PARAMETER	TEST COND	TIONS	MIN	TYP†	MAX	UNIT
Vон	High-level output voltage	$I_{OH} = -1 \text{ mA}$		3.5	V <sub>CC</sub> -0.4 V		V
VOL	Low-level output voltage	I <sub>OL</sub> = 1.6 mA				0.4	V
VIT+	Positive-going input threshold voltage	$V_{CC} = 5 V,$	T <sub>A</sub> = 25°C		1.7	2.4	V
$V_{IT-}$	Negative-going input threshold voltage	$V_{CC} = 5 V,$	T <sub>A</sub> = 25°C	0.8	1.2		V
V <sub>hys</sub>	Input hysteresis (V <sub>IT+</sub> – V <sub>IT</sub> _)			0.2	0.5	1	V
rj	Input resistance	$V_{I} = \pm 3 V \text{ to } \pm 25 V$		3	5	7	kΩ

<sup>†</sup> All typical values are at  $V_{CC} = 5$  V, and  $T_A = 25^{\circ}C$ .

NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F at V<sub>CC</sub> = 5 V ± 0.5 V.

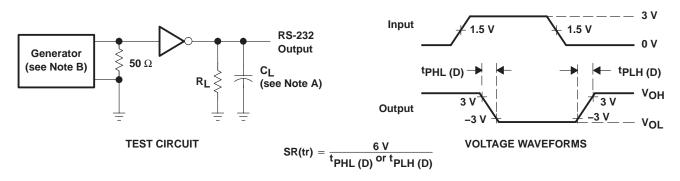
# switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Note 4 and Figure 3)

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
tPLH	Propagation delay time, low- to high-level output	0 450 - 5		0.5	10	μs
<sup>t</sup> PHL	Propagation delay time, high- to low-level output	C <sub>L</sub> = 150 pF		0.5	10	μs
<sup>t</sup> sk(p)	Pulse skew‡			300		ns

<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V, and  $T_A$  = 25°C.

<sup>‡</sup> Pulse skew is defined as  $[t_{PLH} - t_{PHL}]$  of each channel of the same device. NOTE 4: Test conditions are C1–C4 = 0.1  $\mu$ F, at V<sub>CC</sub> = 5 V ± 0.5 V.

#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 120 kbit/s,  $Z_0 = 50 \Omega$ , 50% duty cycle,  $t_f \le 10$  ns.  $t_f \le 10$  ns.

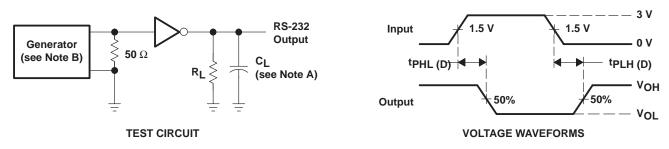
#### Figure 1. Driver Slew Rate



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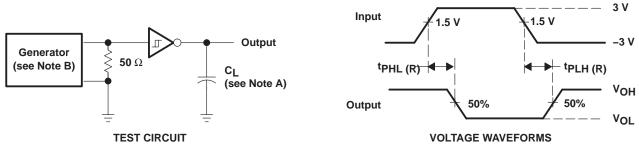
#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>1</sub> includes probe and jig capacitance.

B. The pulse generator has the following characteristics: PRR = 120 kbit/s,  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_f \le 10$  ns.  $t_f \le 10$  ns.

#### Figure 2. Driver Pulse Skew



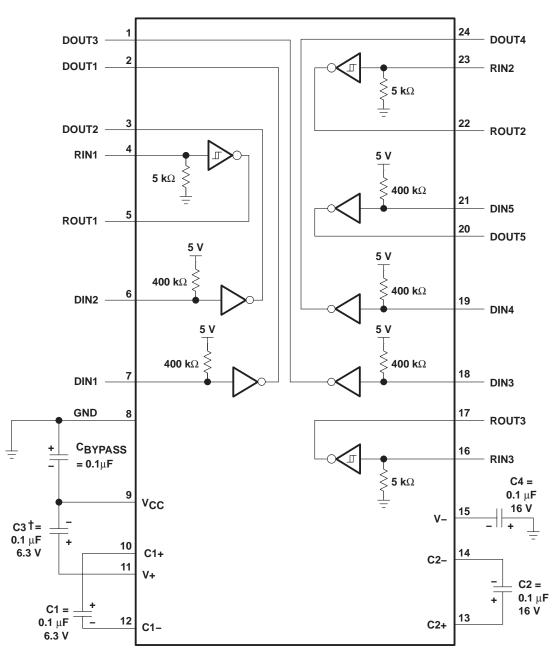
NOTES: A. CL includes probe and jig capacitance.

B. The pulse generator has the following characteristics:  $Z_O = 50 \Omega$ , 50% duty cycle,  $t_r \le 10$  ns,  $t_f \le 10$  ns.

#### **Figure 3. Receiver Propagation Delay Times**



#### **MAX207** 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER WITH ±15-kV ESD PROTECT SLLS592B - OCTOBER 2003 - REVISED JANUARY 2004



**APPLICATION INFORMATION** 

 $^{\dagger}\,\text{C3}$  can be connected to  $\text{V}_{CC}$  or GND.

NOTES: A. Resistor values shown are nominal.

B. Nonpolarized ceramic capacitors are acceptable. If polarized tantalum or electrolytic capacitors are used, they should be connected as shown.

Figure 4. Typical Operating Circuit and Capacitor Values



# **MAX207** 5-V MULTICHANNEL RS-232 LINE DRIVER/RECEIVER WITH ±15-kV ESD PROTECTION

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#### **APPLICATION INFORMATION**

#### capacitor selection

The capacitor type used for C1–C4 is not critical for proper operation. The MAX207 requires 0.1-µF capacitors, although capacitors up to 10 µF can be used without harm. Ceramic dielectrics are suggested for the 0.1-µF capacitors. When using the minimum recommended capacitor values, make sure the capacitance value does not degrade excessively as the operating temperature varies. If in doubt, use capacitors with a larger (e.g., 2×) nominal value. The capacitors' effective series resistance (ESR), which usually rises at low temperatures, influences the amount of ripple on V+ and V-.

Use larger capacitors (up to 10 µF) to reduce the output impedance at V+ and V-.

Bypass  $V_{CC}$  to ground with at least 0.1  $\mu$ F. In applications sensitive to power-supply noise generated by the charge pumps, decouple  $V_{CC}$  to ground with a capacitor the same size as (or larger than) the charge-pump capacitors (C1–C4).

#### **ESD** protection

TI MAX207 devices have standard ESD protection structures incorporated on the pins to protect against electrostatic discharges encountered during assembly and handling. In addition, the RS232 bus pins (driver outputs and receiver inputs) of these devices have an extra level of ESD protection. Advanced ESD structures were designed to successfully protect these bus pins against ESD discharge of ±15-kV when powered down.

#### ESD test conditions

ESD testing is stringently performed by TI, based on various conditions and procedures. Please contact TI for a reliability report that documents test setup, methodology, and results.

#### **Human-Body Model**

The Human-Body Model (HBM) of ESD testing is shown in Figure 5, while Figure 6 shows the current waveform that is generated during a discharge into a low impedance. The model consists of a 100-pF capacitor, charged to the ESD voltage of concern, and subsequently discharged into the device under test (DUT) through a 1.5-k $\Omega$ resistor.

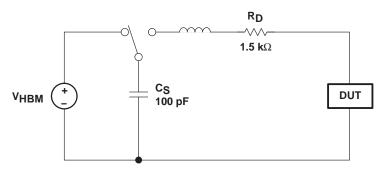


Figure 5. HBM ESD Test Circuit



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#### **APPLICATION INFORMATION**

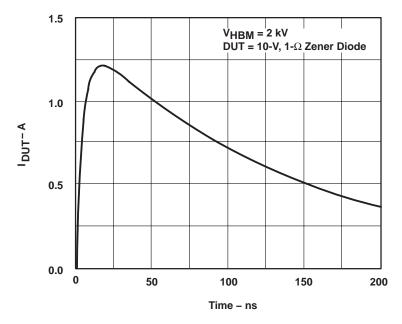


Figure 6. Typical HBM Current Waveform

#### **Machine Model**

The Machine Model (MM) ESD test applies to all pins using a 200-pF capacitor with no discharge resistance. The purpose of the MM test is to simulate possible ESD conditions that can occur during the handling and assembly processes of manufacturing. In this case, ESD protection is required for all pins, not just RS-232 pins. However, after PC board assembly, the MM test no longer is as pertinent to the RS-232 pins.





#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•		Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
MAX207CDB	NRND	SSOP	DB	24	60	RoHS & Green		Level-1-260C-UNLIM	0 to 70	MA207C	
MAX207CDBR	ACTIVE	SSOP	DB	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MA207C	Samples
MAX207CDW	NRND	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX207C	
MAX207CDWR	NRND	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	MAX207C	
MAX207IDB	NRND	SSOP	DB	24	60	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB207I	
MAX207IDBR	ACTIVE	SSOP	DB	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MB207I	Samples
MAX207IDW	NRND	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX207I	
MAX207IDWR	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	MAX207I	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



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Texas

STRUMENTS

#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



All dimensions are nomina										D.		t.
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MAX207CDBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
MAX207CDWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
MAX207IDBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
MAX207IDWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1



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# PACKAGE MATERIALS INFORMATION

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MAX207CDBR	SSOP	DB	24	2000	356.0	356.0	35.0
MAX207CDWR	SOIC	DW	24	2000	350.0	350.0	43.0
MAX207IDBR	SSOP	DB	24	2000	356.0	356.0	35.0
MAX207IDWR	SOIC	DW	24	2000	350.0	350.0	43.0

#### TEXAS INSTRUMENTS

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## TUBE



## - B - Alignment groove width

#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
MAX207CDB	DB	SSOP	24	60	530	10.5	4000	4.1
MAX207CDW	DW	SOIC	24	25	506.98	12.7	4826	6.6
MAX207IDB	DB	SSOP	24	60	530	10.5	4000	4.1
MAX207IDW	DW	SOIC	24	25	506.98	12.7	4826	6.6

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AD.



# **MECHANICAL DATA**

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

## DB (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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